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Substitute for form 1449/PTO				Complete if Known		
•				Application Number	10/579,766-Conf. #3580	
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STATEMENT BY APPLICANT (Use as many sheets as necessary)				First Named Inventor	Takamitsu Yamada	
				Art Unit	2827	
				Examiner Name	Not Yet Assigned	
Sheet	1	of	1	Attorney Docket Number	R2184.0495/P495	

U.S. PATENT DOCUMENTS						
Examiner Cite Name of Patentee or Relevant Passage Name of Patentee or Relevant Passage Relevant Passage Name of Patentee or Name of Patentee or					Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
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Examiner Initials*	Cite No.1	Foreign Patent Document Country Code ³ -Number ⁴ -Kind Code ⁵ (<i>if known</i>)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear	T°	

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	CA	TASIRAN et al.; "Linking Simulation with Formal Verification at a Higher Level"; Synergies for Design Verification; IEEE Design & Test of Computers; Vol. 21, No. 6; Jun 2004; pp. 472-482.			
	СВ	CHEN et al.; "Logic of Constraints: A Quantitative Performance and Functional Constraint Formalism"; IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems; Vol. 23, No. 8; August 2004; pp. 1243-1255.			
	СС	DATTA et al.; "Assertion Based Verification Using HDVL"; Proceedings of the 17th International Conference on VLSI Design; Jan. 2004; pp. 319-325.			
ı	CD	PIXLEY et al.; "Functional Verification 2003: Technology, Tools and Methodology"; Proceedings 5th International Conference, IEEE; Vol. 1; Oct. 2003; pp. 1-5.			

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